

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BOEHNKE ET AL.	
		Examiner Hien Tran	Art Unit 1764	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,026,611	06-1991	Usui et al.	502/527.22
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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